



RADIO TEST REPORT

Test Report No. : 11741240H-A

Applicant : DENSO CORPORATION

Type of Equipment : Blind Spot Monitor Sensor

Model No. : DNSRR004

FCC ID : HYQDNSRR004

Test regulation : FCC Part 15 Subpart C: 2017

Test Result : Complied

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2. The results in this report apply only to the sample tested.
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4. The test results in this report are traceable to the national or international standards.
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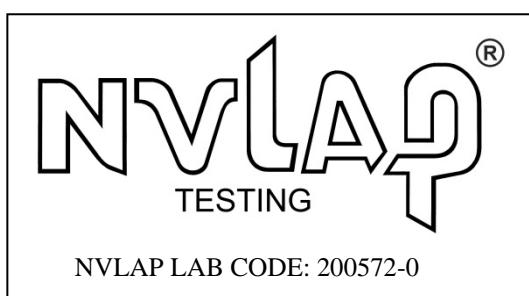
Date of test: June 15 to 17, 2017

Representative test engineer:

Hironobu Ohnishi
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Approved by:

Motoya Imura
Engineer
Consumer Technology Division



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13-EM-F0429

REVISION HISTORY

Original Test Report No.: 11741240H-A

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SECTION 1: Customer information

Company Name : DENSO CORPORATION
Address : 1-1, Showa-cho, Kariya-shi, Aichi-ken, 448-8661 Japan
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Facsimile Number : +81-566-25-4683
Contact Person : Kiyohiko Sawada

SECTION 2: Equipment under test (E.U.T.)

2.1 Identification of E.U.T.

Type of Equipment : Blind Spot Monitor Sensor
Model No. : DNSRR004
Serial No. : Refer to Section 4, Clause 4.2
Rating : DC 12 V (Car battery)
Receipt Date of Sample : May 12, 2017
Country of Mass-production : Japan and United States of America
Condition of EUT : Engineering prototype
(Not for Sale: This sample is equivalent to mass-produced items.)
Modification of EUT : No Modification by the test lab

2.2 Product Description

This Radar Sensor (DNSRR004) is a vehicle-mounted field disturbance sensor which uses millimeter wave for detecting obstacles located diagonally backward.

General Specification

Clock frequency(ies) in the system : Microcomputer: 240 MHz

Radio Specification

Radio Type : Transceiver
Frequency of Operation : 24.15 GHz
Modulation : Frequency modulation
Antenna Type : Internal Antenna
Antenna Connector : None
Antenna Gain : 9.3 dBi (Broad beam), 12.5 dBi (Narrow beam)
Steerable Antenna : Electronically
Usage location : Vehicle-mounted
Power Supply (inner) : DC 3.3 V

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SECTION 3: Test specification, procedures & results

3.1 Test Specification

Test Specification : FCC Part 15 Subpart C
 FCC Part 15 final revised on June 14, 2017 and effective July 14, 2017

Title : FCC 47CFR Part15 Radio Frequency Device Subpart C Intentional Radiators
 Section 15.207 Conducted limits
 Section 15.249 Operation within the bands 902-928MHz,
 2400-2483.5MHz, 5725-5875MHz and 24.0-24.25GHz

* The revision on June 14, 2017, does not affect the test specification applied to the EUT.

3.2 Procedures and results

Item	Test Procedure	Specification	Deviation	Worst margin	Results
Conducted Emission	FCC: ANSI C63.10-2013 6. Standard test methods IC: RSS-Gen 8.8	FCC: Section 15.207 IC: RSS-Gen 8.8	N/A	-	N/A *1)
Electric Field Strength of Fundamental Emission	FCC: ANSI C63.10-2013 6. Standard test methods IC: RSS-Gen 6.12	FCC: Section 15.249(a)(c)(e) IC: RSS-310 3.10	N/A	10.3 dB 24150.00 MHz, Horizontal (Peak with Duty factor) Broad beam	Complied
Electric Field Strength of Spurious Emission	FCC: ANSI C63.10-2013 6. Standard test methods IC: RSS-Gen 6.13	FCC: Section 15.205(a)(b)(d) Section 15.209(a) Section 15.249(a)(c)(d)(e) IC: RSS-310 3.10 RSS-Gen 8.9	N/A	6.7 dB 24250.00 MHz, Horizontal, (Peak with Duty factor) Narrow beam (Right)	Complied
20 dB Bandwidth	FCC: ANSI C63.10-2013 6. Standard test methods IC: -	FCC: Section 15.215 IC: Reference data	N/A	See data.	Complied
Frequency Tolerance	FCC: ANSI C63.10-2013 6. Standard test methods IC: -	FCC: Section 15.249(b) IC: -	N/A	-	N/A *2)
99 % Occupied Bandwidth	FCC: - IC: RSS-Gen 6.6	FCC: Reference data IC: -	N/A	See data.	Complied

*1) The test is not applicable since the EUT is not the device that is designed to be connected to the public utility (AC) power line.

*2) The test is not applicable since the EUT does not operate with Fixed point-to-point operation within 24.05 GHz to 24.25 GHz.

Note: UL Japan, Inc.'s EMI Work Procedures No. 13-EM-W0420 and 13-EM-W0422.

FCC Part 15.31 (e)

The EUT provides stable voltage (DC 3.3 V) constantly to the RF part regardless of input voltage. Instead of a new battery, DC power supply was used for the test.

That does not affect to the test result, therefore the EUT complies with the requirement.

FCC Part 15.203 Antenna requirement

It is impossible for end users to replace the antenna, because the antenna is mounted inside of the EUT. Therefore, the equipment complies with the antenna requirement of Section 15.203.

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3.3 Addition to standard

Other than above, no addition, exclusion nor deviation has been made from the standard.

3.4 Uncertainty

EMI

The following uncertainties have been calculated to provide a confidence level of 95 % using a coverage factor $k=2$.

Test distance	Radiated emission (+/-)	
	9 kHz - 30 MHz	
3m	3.8 dB	
10m	3.6 dB	

*Measurement distance

Polarity	Radiated emission (Below 1GHz)			
	(3 m*)(+/-)		(10 m*)(+/-)	
	30 MHz - 200 MHz	200 MHz - 1000 MHz	30 MHz - 200 MHz	200 MHz - 1000 MHz
Horizontal	5.0 dB	5.3 dB	5.0 dB	5.0 dB
Vertical	5.2 dB	6.3 dB	5.0 dB	5.0 dB

Radiated emission (Above 1GHz)				
(3 m*)(+/-)		(1 m*)(+/-)		(10 m*)(+/-)
1 GHz - 6 GHz	6 GHz - 18 GHz	10 GHz - 26.5 GHz	26.5 GHz - 40 GHz	1 GHz - 18 GHz
5.2 dB	5.5 dB	5.5 dB	5.4 dB	5.5 dB

* Measurement distance

Radiated emission (+dB)	
40 GHz - 50 GHz	4.1 dB
50 GHz - 75 GHz	5.1 dB
75 GHz - 100 GHz	5.4 dB

Radiated emission test

[Electric Field Strength of Fundamental Emission]

The data listed in this test report has enough margin, more than the site margin.

[Electric Field Strength of Spurious Emission]

The data listed in this test report has enough margin, more than the site margin.

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3.5 Test Location

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	IC Registration Number	Width x Depth x Height (m)	Size of reference ground plane (m) / horizontal conducting plane	Other rooms
No.1 semi-anechoic chamber	2973C-1	19.2 x 11.2 x 7.7m	7.0 x 6.0m	No.1 Power source room
No.2 semi-anechoic chamber	2973C-2	7.5 x 5.8 x 5.2m	4.0 x 4.0m	-
No.3 semi-anechoic chamber	2973C-3	12.0 x 8.5 x 5.9m	6.8 x 5.75m	No.3 Preparation room
No.3 shielded room	-	4.0 x 6.0 x 2.7m	N/A	-
No.4 semi-anechoic chamber	2973C-4	12.0 x 8.5 x 5.9m	6.8 x 5.75m	No.4 Preparation room
No.4 shielded room	-	4.0 x 6.0 x 2.7m	N/A	-
No.5 semi-anechoic chamber	-	6.0 x 6.0 x 3.9m	6.0 x 6.0m	-
No.6 shielded room	-	4.0 x 4.5 x 2.7m	4.0 x 4.5 m	-
No.6 measurement room	-	4.75 x 5.4 x 3.0m	4.75 x 4.15 m	-
No.7 shielded room	-	4.7 x 7.5 x 2.7m	4.7 x 7.5m	-
No.8 measurement room	-	3.1 x 5.0 x 2.7m	N/A	-
No.9 measurement room	-	8.0 x 4.6 x 2.8m	2.4 x 2.4m	-
No.11 measurement room	-	6.2 x 4.7 x 3.0m	4.8 x 4.6m	-

* Size of vertical conducting plane (for Conducted Emission test) : 2.0 x 2.0m for No.1, No.2, No.3, and No.4 semi-anechoic chambers and No.3 and No.4 shielded rooms.

3.6 Test data, Test instruments, and Test set up.

Refer to APPENDIX.

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SECTION 4: Operation of E.U.T. during testing

4.1 Operating Modes

Test Item	Mode	Tested frequency
Electric Field Strength of Fundamental Emission	Transmitting mode (Tx)	24.15 GHz
Electric Field Strength of Spurious Emission		
20 dB Bandwidth	Beam setting *1)	FSK setting *2)
99 % Occupied Bandwidth	- Broad beam - Narrow beam (Left) - Narrow beam (Right)	- Hopping (Normal mode) - Hopping Off (Highest)

*1) This EUT has three transmission beam patterns. The tests were performed in these three patterns.

*2) There are FM and FSK modulation parts in one transmission burst. (Hopping mode) The additional test mode was applied to make sure the band-edge compliance. (Hopping Off mode)

The system was configured in typical fashion (as a customer would normally use it) for testing.

*EUT has the power settings by the software as follows;

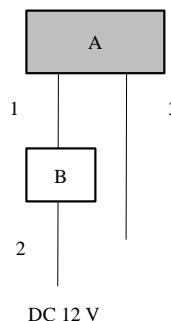
Power Settings: Same as Production model

Software: mwr_24310200

*This setting of software is the worst case.

Any conditions under the normal use do not exceed the condition of setting. In addition, end users cannot change the settings of the output power of the product.

4.2 Configuration and peripherals



* Cabling and setup(s) were taken into consideration and test data was taken under worse case conditions.

Description of EUT

No.	Item	Model number	Serial number	Manufacturer	Remarks
A	Blind Spot Monitor Sensor	DNSRR004	SRR1-NC0066	DENSO CORPORATION	EUT
B	Switch Box	-	-	DENSO CORPORATION	-

List of cables used

No.	Name	Length (m)	Shield		Remarks
			Cable	Connector	
1	DC Cable	2.0	Unshielded	Unshielded	-
2	DC Cable	1.0	Unshielded	Unshielded	-
3	CAN Cable	1.0	Unshielded	Unshielded	-

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SECTION 5: Radiated emission (Electric Field Strength of Fundamental and Spurious Emission)

Test Procedure and conditions

[For below 1 GHz]

EUT was placed on a urethane platform of nominal size, 0.5 m by 1.0 m, raised 0.8 m above the conducting ground plane. The Radiated Electric Field Strength has been measured in a Semi Anechoic Chamber with a ground plane.

[For above 1 GHz, up to 40 GHz]

EUT was placed on a urethane platform of nominal size, 0.5 m by 0.5 m, raised 1.5 m above the conducting ground plane. The Radiated Electric Field Strength has been measured in a Semi Anechoic Chamber with absorbent materials lined on a ground plane.

The height of the measuring antenna varied between 1 m and 4 m (frequency range 9 kHz – 30 MHz: loop antenna was fixed height at 1.0 m) and EUT was rotated a full revolution in order to obtain the maximum value of the electric field strength.

The measurements were performed for both vertical and horizontal antenna polarization with the Test Receiver, or the Spectrum Analyzer.

The measurements were made with the following detector function of the test receiver and the Spectrum analyzer (in linear voltage average mode).

The test was made with the detector (RBW/VBW) in the following table.

When using Spectrum analyzer, the test was made with adjusting span to zero by using peak hold.

Test Antennas are used as below;

Frequency	Below 30 MHz	30 MHz to 200 MHz	200 MHz to 1 GHz	Above 1 GHz
Antenna Type	Loop	Biconical	Logperiodic	Horn

Frequency	9 kHz – 150 kHz	150 kHz – 30 MHz	30 MHz – 1 GHz	1 GHz – 40 GHz
Instrument used	Test Receiver	Test Receiver	Test Receiver	Spectrum Analyzer
Detector	QP, Average	QP, Average	QP	Peak
IF Bandwidth	BW 200 Hz	BW 9 kHz	BW 120 kHz	RBW: 1 MHz VBW: 3 MHz Pulsed emission - RBW: 1 MHz - Peak with duty Other than above - RBW: 1 MHz - VBW: 10 Hz
Test Distance	3 m	3 m	3 m	4.5 m *2) (1 GHz – 10 GHz) 1 m*3) (10 GHz – 26.5 GHz), 0.5 m*4) (26.5 GHz – 40 GHz)

*1) For Pulsed emission (Fundamental and band-edge): The Average value was calculated by reducing Duty factor from Peak (Peak value – Duty factor). For Duty factor, please refer to page Duty factor measurement. Other than pulsed emission, aVBW was set to 10 Hz and linear voltage average mode was used.

*2) Distance Factor: $20 \times \log (4.5 \text{ m} / 3.0 \text{ m}) = 3.5 \text{ dB}$

*3) Distance Factor: $20 \times \log (1.0 \text{ m} / 3.0 \text{ m}) = -9.5 \text{ dB}$

*4) Distance Factor: $20 \times \log (0.5 \text{ m} / 3.0 \text{ m}) = -15.6 \text{ dB}$

[About fundamental measurement]

The carrier levels were confirmed at maximum direction of transmission. The maximum direction was searched under carefully since beam-widths are narrow.

The carrier levels were measured in the far field. The distance of the far field was calculated from follow equation.

$$r = \frac{2D^2}{\lambda}$$

where

r is the distance from the radiating element of the EUT to the edge of the far field, in m

D is the largest dimension of both the radiating element and the test antenna (horn), in m

(The antenna aperture size of test antenna was used for this calculation.)

λ is the wavelength of the emission under investigation [$300 / f(\text{MHz}) * 10^3$], in millimeter

Frequency [GHz]	Wavelength λ [mm]	Maximum Dimension			Far Field Boundary r [m]
		EUT [m]	Test Antenna (MHA-16) [m]	Maximum D [m]	
24.250	12.4	0.028	0.075	0.075	0.910

[Above 40 GHz]

The test was performed based on “Procedures for testing millimeter-wave systems” of ANSI C63.10-2013. The EUT was placed on an urethane platform, raised 1.5 m above the conducting ground plane. The measurements were performed on handheld method.

Set spectrum analyzer RBW, VBW, span, etc., to the proper values. Note these values. Enable two traces—one set to “clear write,” and the other set to “max hold.” Begin hand-held measurements with the test antenna (horn) at a distance of 1 m from the EUT in a horizontally polarized position. Slowly adjust its position, entirely covering the plane 1 m from the EUT. Observation of the two active traces on the spectrum analyzer will allow refined horn positioning at the point(s) of maximum field intensity. Repeat with the horn in a vertically polarized position. If the emission cannot be detected at 1 m, reduce the RBW to increase system sensitivity. Note the value. If the emission still cannot be detected, move the horn closer to the EUT, noting the distance at which a measurement is made.

Note the maximum level indicated on the spectrum analyzer. Adjust this level, if necessary, by the antenna gain, conversion loss of the external mixer and gain of LNA used, at the frequency under investigation. Calculate the field strength of the emission at the measurement distance from the Friis’ transmission equation.

Frequency	40 GHz – 50 GHz	50 GHz – 75 GHz	75 GHz – 100 GHz
Final measurement distance with 1 MHz Peak detector	0.5 m	0.25 m	0.25 m

Detector	Peak	Average *1)	
IF Bandwidth	RBW: 1 MHz VBW: 3 MHz	Pulsed emission - RBW: 1 MHz - Peak with duty	Other than pulsed - RBW: 1 MHz - VBW: 10 Hz

*1) For Pulsed emission: The Average value was calculated by reducing Duty factor from Peak (Peak value – Duty factor). For Duty factor, please refer to page Duty factor measurement. Other than pulsed emission, a VBW was set to 10 Hz and linear voltage average mode was used.

- The carrier level and noise levels were confirmed at each position of X and Y axes of EUT to see the position of maximum noise, and the test was made at the position that has the maximum noise.

The test results and limit are rounded off to one decimal place, so some differences might be observed.

Measurement range : 9 kHz – 100 GHz
Test data : APPENDIX
Test result : Pass

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SECTION 6: 20 dB Bandwidth, 99 % Occupied Bandwidth and Duty Cycle

Test Procedure

The measurement was performed in the antenna height to gain the maximum of Electric field strength.

Test	Span	RBW	VBW	Sweep	Detector	Trace	Instrument used
20 dB Bandwidth	600 MHz	2 MHz 1 % to 5 % of OBW	6 MHz Three times of RBW	60 sec	Peak	Max Hold	Spectrum Analyzer
99 % Occupied Bandwidth	600 MHz, Enough width to display emission skirts	2 MHz, 1 % to 5 % of OBW	6 MHz, Three times of RBW	60 sec	Peak *1)	Max Hold *2)	Spectrum Analyzer
Duty Cycle	-	-	-	200 msec	-	Single	Oscilloscope

*1) Peak detector was applied as Worst-case measurement.

*2) The measurement was performed with Max Hold since the duty cycle was not 100 %.

: APPENDIX

: Pass

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APPENDIX 1: Test data

Radiated Emission (Electric Field Strength of Fundamental and Spurious Emission)

Report No.	11741240H								
Test place	Ise EMC Lab.								
Semi Anechoic Chamber	No. 3			No. 3					
Date	June 15, 2017			June 16, 2017					
Temperature / Humidity	24 deg. C / 44 % RH			25 deg. C / 42 % RH					
	18 GHz - 26.5 GHz			10 GHz - 18 GHz					
Engineer	Hironobu OHnishi								
Mode	Tx 24.15 GHz, Broad beam								

[Fundamental, band-edge]

Frequency [MHz]	Detector	Reading [dBuV]		Ant Factor [dB/m]	Loss [dB]	Gain [dB]	Duty Factor [dB]	Result (3 m) [dBuV/m]		Limit (3 m) [dBuV/m]	Margin [dB]		Remark Inside or Outside of Restricted Bands
		Hor	Ver					Hor	Ver		Hor	Ver	
24000.00	Peak	46.4	46.6	38.3	-0.4	31.8	-	52.5	52.7	73.9	21.4	21.2	Inside
24150.00	Peak	98.0	97.8	38.4	-0.3	31.7	-	104.4	104.2	127.9	23.5	23.7	Fundamental
24250.00	Peak	47.3	47.1	38.4	-0.3	31.6	-	53.8	53.6	73.9	20.1	20.3	Outside

Result = Reading + Ant Factor + Loss (Cable+Attenuator+Filter+Distance Factor) - Gain(Amplifier)

Peak with Duty factor

Frequency [MHz]	Detector	Reading [dBuV]		Ant Factor [dB/m]	Loss [dB]	Gain [dB]	Duty Factor [dB]	Result [dBuV/m]		Limit [dBuV/m]	Margin [dB]		Remark
		Hor	Ver					Hor	Ver		Hor	Ver	
24000.00	Peak	46.4	46.6	38.3	-0.4	31.8	-6.8	45.7	45.9	53.9	8.2	8.0	Inside
24150.00	Peak	98.0	97.8	38.4	-0.3	31.7	-6.8	97.6	97.4	107.9	10.3	10.5	Fundamental
24250.00	Peak	47.3	47.1	38.4	-0.3	31.6	-6.8	47.0	46.8	53.9	6.9	7.1	Outside

Result = Reading + Ant Factor + Loss (Cable+Attenuator+Filter+Distance Factor) - Gain(Amplifier) + Duty factor (Refer to Duty factor data sheet)

[Spurious emissions other than above]

Polarity	Frequency [MHz]	Detector	Reading [dBuV]	Ant.Fac. [dB/m]	Loss [dB]	Gain [dB]	Result [dBuV/m]	Limit [dBuV/m]	Margin [dB]	Remark
Hori	38.000	QP	22.1	15.1	7.3	32.2	12.3	40.0	27.7	
Hori	120.000	QP	22.3	13.0	8.4	32.2	11.5	43.5	32.0	
Hori	240.000	QP	21.9	11.7	9.5	32.0	11.1	46.0	34.9	
Hori	480.000	QP	21.8	17.3	11.2	32.0	18.3	46.0	27.7	
Hori	720.000	QP	22.0	19.9	12.5	32.0	22.4	46.0	23.6	
Hori	960.000	QP	20.9	22.3	13.7	30.7	26.2	46.0	19.8	
Hori	48300.000	PK	48.0	41.7	-7.2	32.6	49.9	87.9	38.0	
Hori	72450.000	PK	40.2	41.7	-4.5	21.0	56.4	87.9	31.5	
Hori	96600.000	PK	45.7	45.6	-9.6	28.7	53.0	73.9	20.9	
Hori	48300.000	AV	35.2	41.7	-7.2	32.6	37.1	67.9	30.8	NS VBW:10Hz Voltage Avg
Hori	72450.000	AV	26.4	41.7	-4.5	21.0	42.6	67.9	25.3	NS VBW 10Hz Voltage Avg
Hori	96600.000	AV	32.9	45.6	-9.6	28.7	40.2	53.9	13.7	NS VBW 10Hz Voltage Avg
Vert	40.080	QP	27.4	14.3	7.3	32.2	16.8	40.0	23.2	
Vert	52.204	QP	27.0	10.1	7.5	32.2	12.4	40.0	27.6	
Vert	82.080	QP	28.5	6.7	7.9	32.2	10.9	40.0	29.1	
Vert	120.000	QP	22.3	13.0	8.4	32.2	11.5	43.5	32.0	
Vert	240.000	QP	22.0	11.7	9.5	32.0	11.2	46.0	34.8	
Vert	480.000	QP	21.7	17.3	11.2	32.0	18.2	46.0	27.8	
Vert	720.000	QP	22.1	19.9	12.5	32.0	22.5	46.0	23.5	
Vert	960.000	QP	20.9	22.3	13.7	30.7	26.2	46.0	19.8	
Vert	48300.000	PK	47.7	41.7	-7.2	32.6	49.6	87.9	38.3	
Vert	72450.000	PK	40.3	41.7	-4.5	21.0	56.5	87.9	31.4	
Vert	96600.000	PK	45.8	45.6	-9.6	28.7	53.1	73.9	20.8	
Vert	48300.000	AV	35.0	41.7	-7.2	32.6	36.9	67.9	31.0	NS VBW:10Hz Voltage Avg
Vert	72450.000	AV	26.3	41.7	-4.5	21.0	42.5	67.9	25.4	NS VBW 10Hz Voltage Avg
Vert	96600.000	AV	32.8	45.6	-9.6	28.7	40.1	53.9	13.8	NS VBW 10Hz Voltage Avg

Result = Reading + Ant Factor + Loss (Cable+Attenuator+Filter+Mixer(above 50 GHz)+Distance factor(above 1 GHz)) - Gain(Amplifier)

*Other frequency noises omitted in this report were not seen or had enough margin (more than 20 dB).

*NS: No signal detected.

Distance factor: 1 GHz - 10 GHz $20\log(4.5 \text{ m} / 3.0 \text{ m}) = 3.5 \text{ dB}$

10 GHz - 26.5 GHz $20\log(1.0 \text{ m} / 3.0 \text{ m}) = -9.5 \text{ dB}$

26.5 GHz - 50 GHz $20\log(0.5 \text{ m} / 3.0 \text{ m}) = -15.6 \text{ dB}$

50 GHz - 100 GHz $20\log(0.25 \text{ m} / 3.0 \text{ m}) = -21.6 \text{ dB}$

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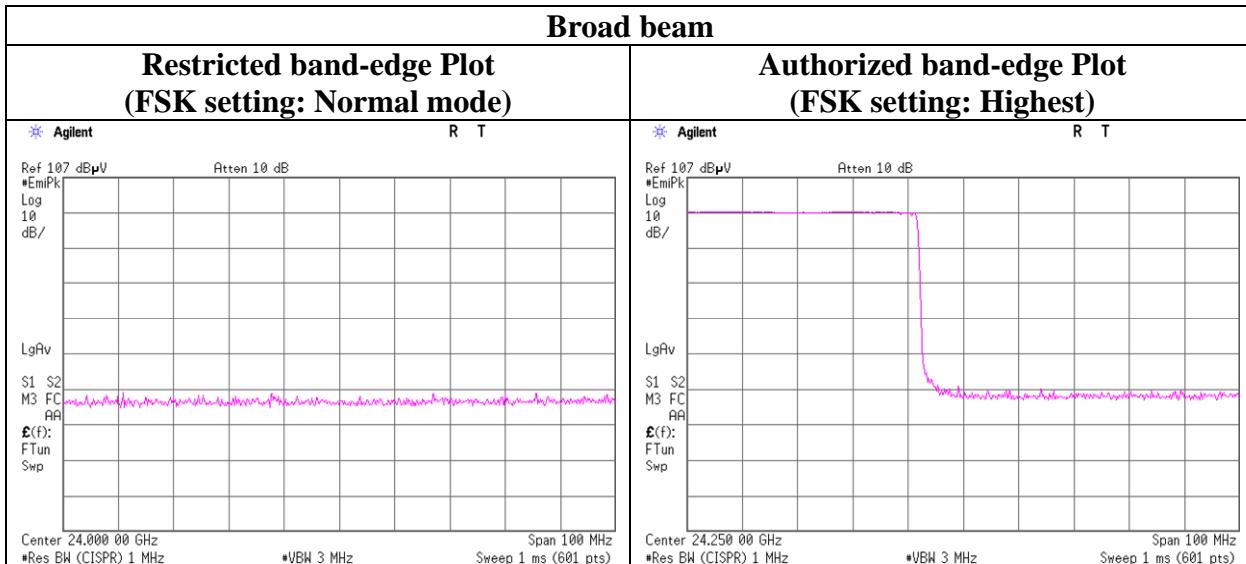
4383-326 Asama-cho, Ise-shi, Mie-ken 516-0021 JAPAN

Telephone : +81 596 24 8999

Facsimile : +81 596 24 8124

**Radiated Spurious Emission
 (Reference Plot for band-edge)**

Test place Ise EMC Lab. No. 3 Semi Anechoic Chamber
 Report No. 11741240H
 Date June 15, 2017
 Temperature / Humidity 24 deg. C / 44 % RH
 Engineer Hironobu OHnishi
 Mode Tx 24.15 GHz, Broad beam



* Final result of restricted band edge was shown in tabular data.

The test was performed on two FSK settings in consideration of the worst case measurement.

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Ise EMC Lab.

4383-326 Asama-cho, Ise-shi, Mie-ken 516-0021 JAPAN

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Radiated Emission (Electric Field Strength of Fundamental and Spurious Emission)

Report No.	11741240H		
Test place	Ise EMC Lab.		
Semi Anechoic Chamber	No. 3	No. 3	No. 3
Date	June 15, 2017	June 16, 2017	June 17, 2017
Temperature / Humidity	24 deg. C / 44 % RH 18 GHz - 26.5 GHz	25 deg. C / 42 % RH 10 GHz - 18 GHz	22 deg. C / 47 % RH 9 kHz - 10 GHz
		26.5 GHz - 100 GHz	
Engineer	Hironobu OHnishi		
Mode	Tx 24.15 GHz, Narrow beam(Left)		

[Fundamental, band-edge]

Peak

Frequency [MHz]	Detector	Reading [dBuV]		Ant Factor [dB/m]	Loss [dB]	Gain [dB]	Duty Factor [dB]	Result (3 m) [dBuV/m]		Limit (3 m) [dBuV/m]	Margin [dB]		Remark Inside or Outside of Restricted Bands
		Hor	Ver					Hor	Ver		Hor	Ver	
24000.00	Peak	46.1	45.9	38.3	4.0	31.8	-	56.6	56.4	73.9	17.3	17.5	Inside
24150.00	Peak	97.8	97.5	38.4	-0.3	31.7	-	104.2	103.9	127.9	23.7	24.0	Fundamental
24250.00	Peak	47.0	46.9	38.4	-0.3	31.6	-	53.5	53.4	73.9	20.4	20.5	Outside

Result = Reading + Ant Factor + Loss (Cable+Attenuator+Filter+Distance Factor) - Gain(Amplifier)

Peak with Duty factor

Frequency [MHz]	Detector	Reading [dBuV]		Ant Factor [dB/m]	Loss [dB]	Gain [dB]	Duty Factor [dB]	Result [dBuV/m]		Limit [dBuV/m]	Margin [dB]		Remark
		Hor	Ver					Hor	Ver		Hor	Ver	
24000.00	Peak	46.1	45.9	38.3	4.0	31.8	-6.8	49.8	49.6	53.9	4.1	4.3	Inside
24150.00	Peak	97.8	97.5	38.4	-0.3	31.7	-6.8	97.4	97.1	107.9	10.5	10.8	Fundamental
24250.00	Peak	47.0	46.9	38.4	-0.3	31.6	-6.8	46.7	46.6	53.9	7.2	7.3	Outside

Result = Reading + Ant Factor + Loss (Cable+Attenuator+Filter+Distance Factor) - Gain(Amplifier) + Duty factor (Refer to Duty factor data sheet)

[Spurious emissions other than above]

Polarity	Frequency [MHz]	Detector	Reading [dBuV]	Ant.Fac. [dB/m]	Loss [dB]	Gain [dB]	Result [dBuV/m]	Limit [dBuV/m]	Margin [dB]	Remark
Hori	38.000	QP	22.2	15.1	7.3	32.2	12.4	40.0	27.6	
Hori	120.000	QP	22.3	13.0	8.4	32.2	11.5	43.5	32.0	
Hori	240.000	QP	22.0	11.7	9.5	32.0	11.2	46.0	34.8	
Hori	480.000	QP	21.8	17.3	11.2	32.0	18.3	46.0	27.7	
Hori	720.000	QP	22.1	19.9	12.5	32.0	22.5	46.0	23.5	
Hori	960.000	QP	21.0	22.3	13.7	30.7	26.3	46.0	19.7	
Hori	48300.000	PK	47.9	41.7	-7.2	32.6	49.8	87.9	38.1	
Hori	72450.000	PK	39.5	41.7	-4.5	21.0	55.7	87.9	32.2	
Hori	96600.000	PK	45.4	45.6	-9.6	28.7	52.7	73.9	21.2	
Hori	48300.000	AV	35.3	41.7	-7.2	32.6	37.2	67.9	30.7	NS VBW:10Hz Voltage Avg
Hori	72450.000	AV	26.4	41.7	-4.5	21.0	42.6	67.9	25.3	NS VBW 10Hz Voltage Avg
Hori	96600.000	AV	32.8	45.6	-9.6	28.7	40.1	53.9	13.8	NS VBW 10Hz Voltage Avg
Vert	40.080	QP	27.4	14.3	7.3	32.2	16.8	40.0	23.2	
Vert	52.204	QP	27.1	10.1	7.5	32.2	12.5	40.0	27.5	
Vert	82.080	QP	28.0	6.7	7.9	32.2	10.4	40.0	29.6	
Vert	120.000	QP	22.2	13.0	8.4	32.2	11.4	43.5	32.1	
Vert	240.000	QP	22.1	11.7	9.5	32.0	11.3	46.0	34.7	
Vert	480.000	QP	21.8	17.3	11.2	32.0	18.3	46.0	27.7	
Vert	720.000	QP	22.1	19.9	12.5	32.0	22.5	46.0	23.5	
Vert	960.000	QP	21.0	22.3	13.7	30.7	26.3	46.0	19.7	
Vert	48300.000	PK	47.9	41.7	-7.2	32.6	49.8	87.9	38.1	
Vert	72450.000	PK	39.8	41.7	-4.5	21.0	56.0	87.9	31.9	
Vert	96600.000	PK	45.6	45.6	-9.6	28.7	52.9	73.9	21.0	
Vert	48300.000	AV	35.0	41.7	-7.2	32.6	36.9	67.9	31.0	NS VBW:10Hz Voltage Avg
Vert	72450.000	AV	26.4	41.7	-4.5	21.0	42.6	67.9	25.3	NS VBW 10Hz Voltage Avg
Vert	96600.000	AV	32.8	45.6	-9.6	28.7	40.1	53.9	13.8	NS VBW 10Hz Voltage Avg

Result = Reading + Ant Factor + Loss (Cable+Attenuator+Filter+Mixer(above 50 GHz)+Distance factor(above 1 GHz)) - Gain(Amplifier)

*Other frequency noises omitted in this report were not seen or had enough margin (more than 20 dB).

*NS: No signal detected.

Distance factor: 1 GHz - 10 GHz 20log (4.5 m / 3.0 m) = 3.5 dB
 10 GHz - 26.5 GHz 20log (1.0 m / 3.0 m) = -9.5 dB
 26.5 GHz - 50 GHz 20log (0.5 m / 3.0 m) = -15.6 dB
 50 GHz - 100 GHz 20log (0.25 m / 3.0 m) = -21.6 dB

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Ise EMC Lab.

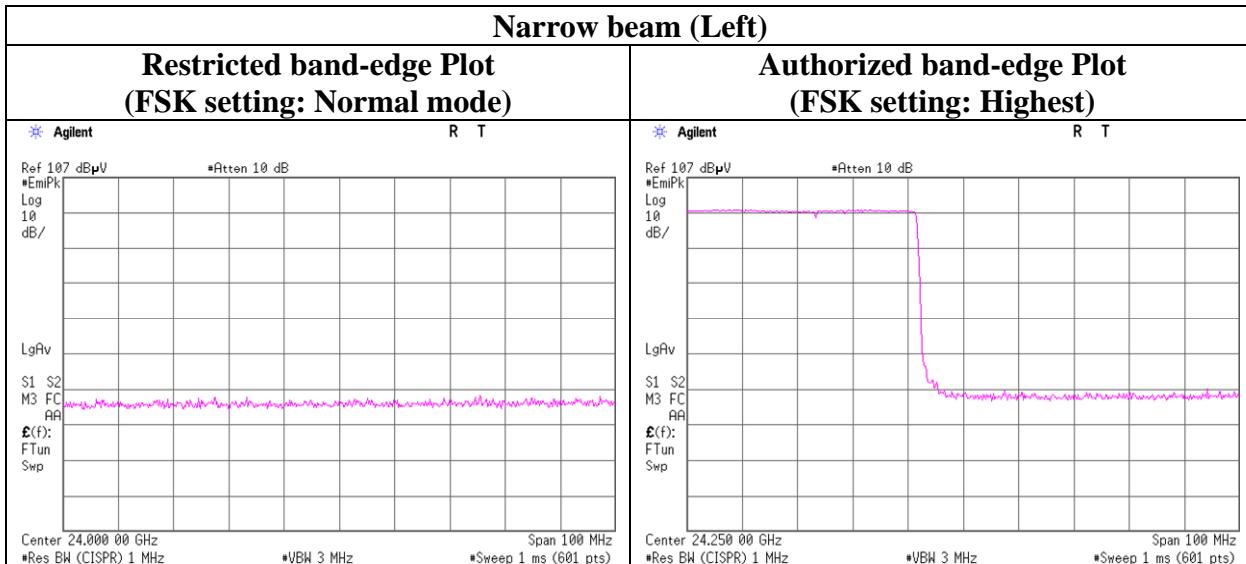
4383-326 Asama-cho, Ise-shi, Mie-ken 516-0021 JAPAN

Telephone : +81 596 24 8999

Facsimile : +81 596 24 8124

**Radiated Spurious Emission
 (Reference Plot for band-edge)**

Test place Ise EMC Lab. No. 3 Semi Anechoic Chamber
 Report No. 11741240H
 Date June 15, 2017
 Temperature / Humidity 24 deg. C / 44 % RH
 Engineer Hironobu OHnishi
 Mode Tx 24.15 GHz, Narrow beam(Left)



* Final result of restricted band edge was shown in tabular data.

The test was performed on two FSK settings in consideration of the worst case measurement.

UL Japan, Inc.

Ise EMC Lab.

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Radiated Emission (Electric Field Strength of Fundamental and Spurious Emission)

Report No.	11741240H					
Test place	Ise EMC Lab.					
Semi Anechoic Chamber	No. 3		No. 3		No. 3	
Date	June 15, 2017		June 16, 2017		June 17, 2017	
Temperature / Humidity	24 deg. C / 44 % RH	25 deg. C / 42 % RH	22 deg. C / 47 % RH			
	18 GHz - 26.5 GHz	10 GHz - 18 GHz	9 kHz - 10 GHz			
		26.5 GHz - 100 GHz				
Engineer	Hironobu OHnishi					
Mode	Tx 24.15 GHz, Narrow beam(Right)					

[Fundamental, band-edge]

Peak

Frequency [MHz]	Detector	Reading [dBuV]		Ant Factor [dB/m]	Loss [dB]	Gain [dB]	Duty Factor [dB]	Result (3 m) [dBuV/m]		Limit (3 m) [dBuV/m]	Margin [dB]		Remark Inside or Outside of Restricted Bands
		Hor	Ver					Hor	Ver		Hor	Ver	
24000.00	Peak	45.9	46.4	-38.3	-0.4	31.8	-	-24.6	-24.1	73.9	98.5	98.0	Inside
24150.00	Peak	97.5	97.6	38.4	-0.3	31.7	-	103.9	104.0	127.9	24.0	23.9	Fundamental
24250.00	Peak	47.5	47.4	38.4	-0.3	31.6	-	54.0	53.9	73.9	19.9	20.0	Outside

Result = Reading + Ant Factor + Loss (Cable+Attenuator+Filter+Distance Factor) - Gain(Amplifier)

Peak with Duty factor

Frequency [MHz]	Detector	Reading [dBuV]		Ant Factor [dB/m]	Loss [dB]	Gain [dB]	Duty Factor [dB]	Result [dBuV/m]		Limit [dBuV/m]	Margin [dB]		Remark
		Hor	Ver					Hor	Ver		Hor	Ver	
24000.00	Peak	45.9	46.4	-38.3	-0.4	31.8	-6.8	-31.4	-30.9	53.9	85.3	84.8	Inside
24150.00	Peak	97.5	97.6	38.4	-0.3	31.7	-6.8	97.1	97.2	107.9	10.8	10.7	Fundamental
24250.00	Peak	47.5	47.4	38.4	-0.3	31.6	-6.8	47.2	47.1	53.9	6.7	6.8	Outside

Result = Reading + Ant Factor + Loss (Cable+Attenuator+Filter+Distance Factor) - Gain(Amplifier) + Duty factor (Refer to Duty factor data sheet)

[Spurious emissions other than above]

Polarity	Frequency [MHz]	Detector	Reading [dBuV]	Ant.Fac. [dB/m]	Loss [dB]	Gain [dB]	Result [dBuV/m]	Limit [dBuV/m]	Margin [dB]	Remark		
Hori	38.000	QP	22.1	15.1	7.3	32.2	12.3	40.0	27.7			
Hori	120.000	QP	22.2	13.0	8.4	32.2	11.4	43.5	32.1			
Hori	240.000	QP	22.1	11.7	9.5	32.0	11.3	46.0	34.7			
Hori	480.000	QP	21.7	17.3	11.2	32.0	18.2	46.0	27.8			
Hori	720.000	QP	22.1	19.9	12.5	32.0	22.5	46.0	23.5			
Hori	960.000	QP	20.9	22.3	13.7	30.7	26.2	46.0	19.8			
Hori	48300.000	PK	47.8	41.7	-7.2	32.6	49.7	87.9	38.2			
Hori	72450.000	PK	39.1	41.7	-4.5	21.0	55.3	87.9	32.6			
Hori	96600.000	PK	45.6	45.6	-9.6	28.7	52.9	73.9	21.0			
Hori	48300.000	AV	35.2	41.7	-7.2	32.6	37.1	67.9	30.8	NS VBW:10Hz Voltage Avg		
Hori	72450.000	AV	26.3	41.7	-4.5	21.0	42.5	67.9	25.4	NS VBW 10Hz Voltage Avg		
Hori	96600.000	AV	32.8	45.6	-9.6	28.7	40.1	53.9	13.8	NS VBW 10Hz Voltage Avg		
Vert	40.080	QP	27.2	14.3	7.3	32.2	16.6	40.0	23.4			
Vert	52.204	QP	27.0	10.1	7.5	32.2	12.4	40.0	27.6			
Vert	82.080	QP	28.3	6.7	7.9	32.2	10.7	40.0	29.3			
Vert	120.000	QP	22.3	13.0	8.4	32.2	11.5	43.5	32.0			
Vert	240.000	QP	22.1	11.7	9.5	32.0	11.3	46.0	34.7			
Vert	480.000	QP	21.7	17.3	11.2	32.0	18.2	46.0	27.8			
Vert	720.000	QP	22.0	19.9	12.5	32.0	22.4	46.0	23.6			
Vert	960.000	QP	20.9	22.3	13.7	30.7	26.2	46.0	19.8			
Vert	48300.000	PK	48.0	41.7	-7.2	32.6	49.9	87.9	38.0			
Vert	72450.000	PK	39.3	41.7	-4.5	21.0	55.5	87.9	32.4			
Vert	96600.000	PK	45.5	45.6	-9.6	28.7	52.8	73.9	21.1			
Vert	48300.000	AV	35.2	41.7	-7.2	32.6	37.1	67.9	30.8	NS VBW:10Hz Voltage Avg		
Vert	72450.000	AV	26.3	41.7	-4.5	21.0	42.5	67.9	25.4	NS VBW 10Hz Voltage Avg		
Vert	96600.000	AV	32.8	45.6	-9.6	28.7	40.1	53.9	13.8	NS VBW 10Hz Voltage Avg		

Result = Reading + Ant Factor + Loss (Cable+Attenuator+Filter+Mixer(above 50 GHz)+Distance factor(above 1 GHz)) - Gain(Amplifier)

*Other frequency noises omitted in this report were not seen or had enough margin (more than 20 dB).

*NS: No signal detected.

Distance factor: 1 GHz - 10 GHz $20\log(4.5 \text{ m} / 3.0 \text{ m}) = 3.5 \text{ dB}$

10 GHz - 26.5 GHz $20\log(1.0 \text{ m} / 3.0 \text{ m}) = -9.5 \text{ dB}$

26.5 GHz - 50 GHz $20\log(0.5 \text{ m} / 3.0 \text{ m}) = -15.6 \text{ dB}$

50 GHz - 100 GHz $20\log(0.25 \text{ m} / 3.0 \text{ m}) = -21.6 \text{ dB}$

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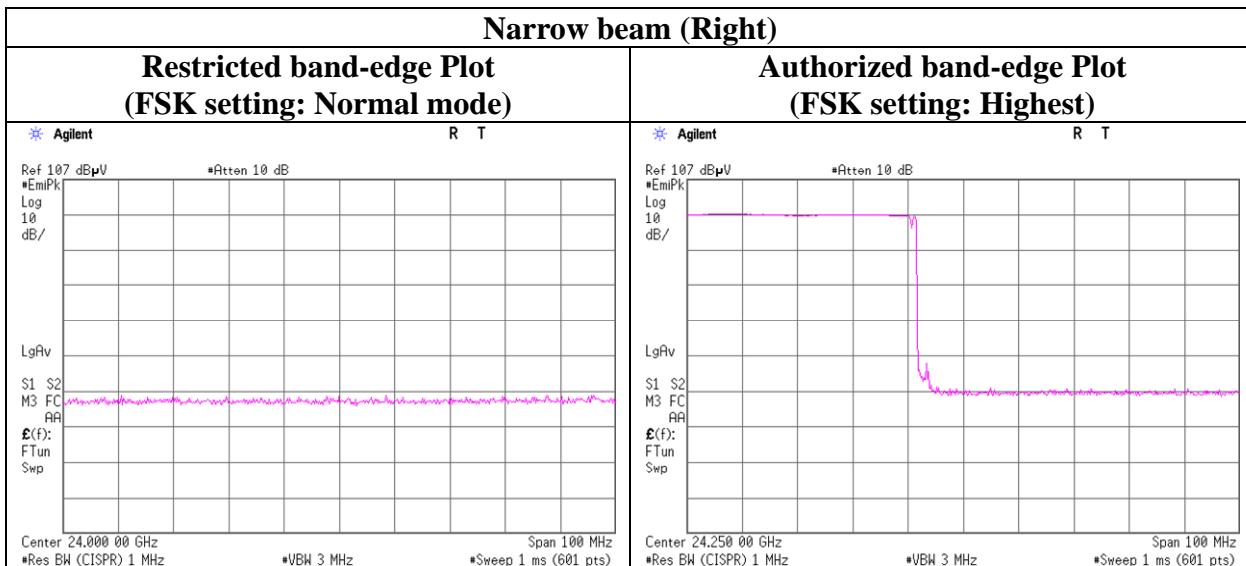
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**Radiated Spurious Emission
 (Reference Plot for band-edge)**

Test place Ise EMC Lab. No. 3 Semi Anechoic Chamber
 Report No. 11741240H
 Date June 15, 2017
 Temperature / Humidity 24 deg. C / 44 % RH
 Engineer Hironobu OHnishi
 Mode Tx 24.15 GHz, Narrow beam(Right)



* Final result of restricted band edge was shown in tabular data.

The test was performed on two FSK settings in consideration of the worst case measurement.

UL Japan, Inc.

Ise EMC Lab.

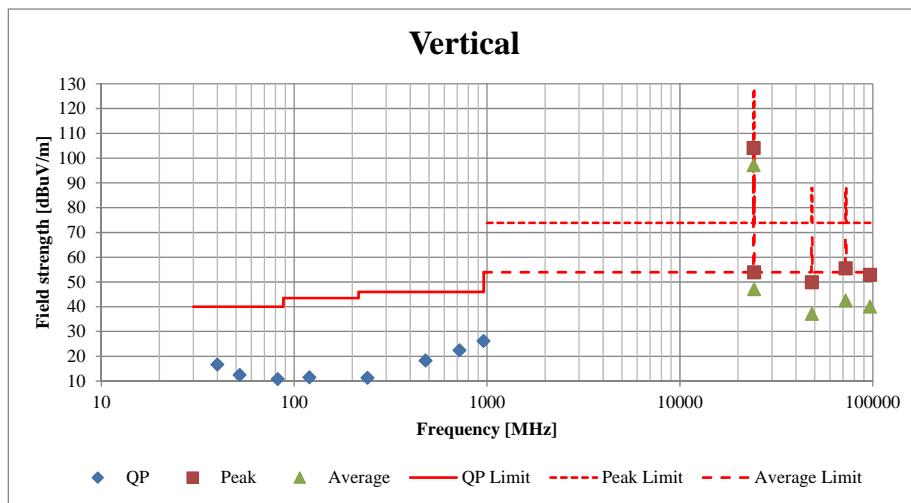
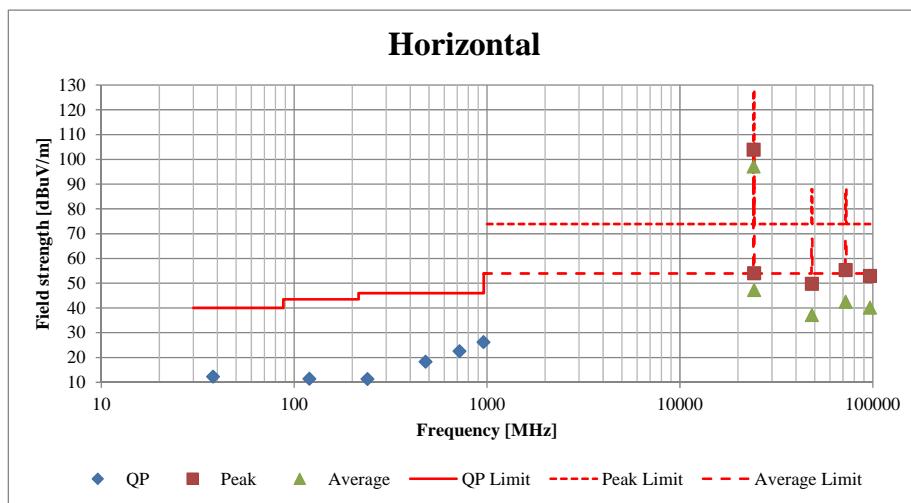
4383-326 Asama-cho, Ise-shi, Mie-ken 516-0021 JAPAN

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Radiated Emission (Electric Field Strength of Fundamental and Spurious Emission)

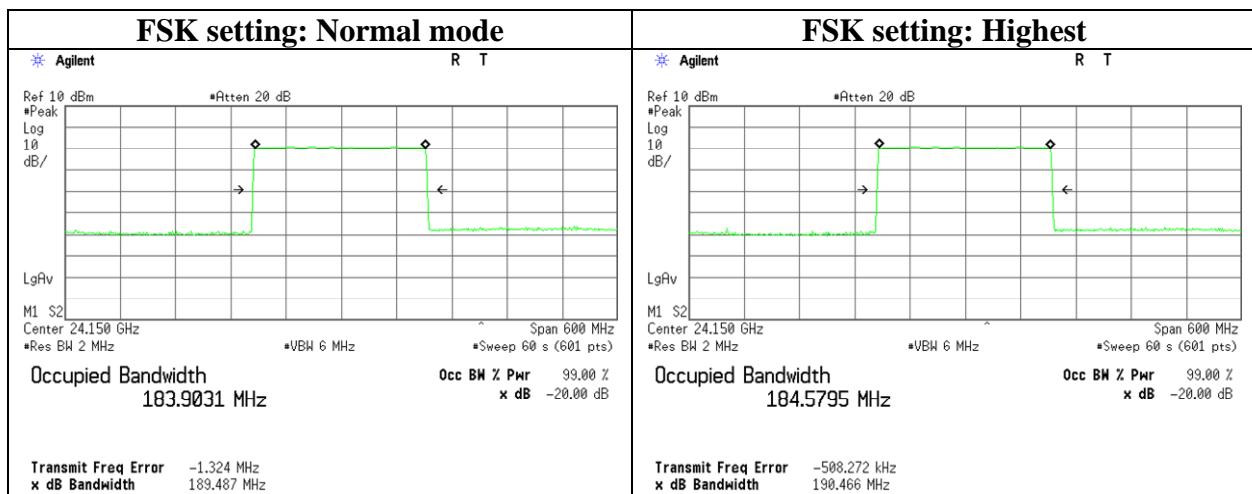
Report No.	11741240H		
Test place	Ise EMC Lab.		
Semi Anechoic Chamber	No. 3	No. 3	No. 3
Date	June 15, 2017	June 16, 2017	June 17, 2017
Temperature / Humidity	24 deg. C / 44 % RH	25 deg. C / 42 % RH	22 deg. C / 47 % RH
	18 GHz - 26.5 GHz	10 GHz - 18 GHz	9 kHz - 10 GHz
		26.5 GHz - 100 GHz	
Engineer	Hironobu OHnishi		
Mode	Tx 24.15 GHz, Narrow beam(Right)		



20dB Bandwidth, 99% Occupied Bandwidth

Test place Ise EMC Lab. No. 3 Semi Anechoic Chamber
 Report No. 11741240H
 Date June 15, 2017
 Temperature / Humidity 24 deg. C / 44 % RH
 Engineer Hironobu OHnishi
 Mode Tx 24.15 GHz, Broad beam

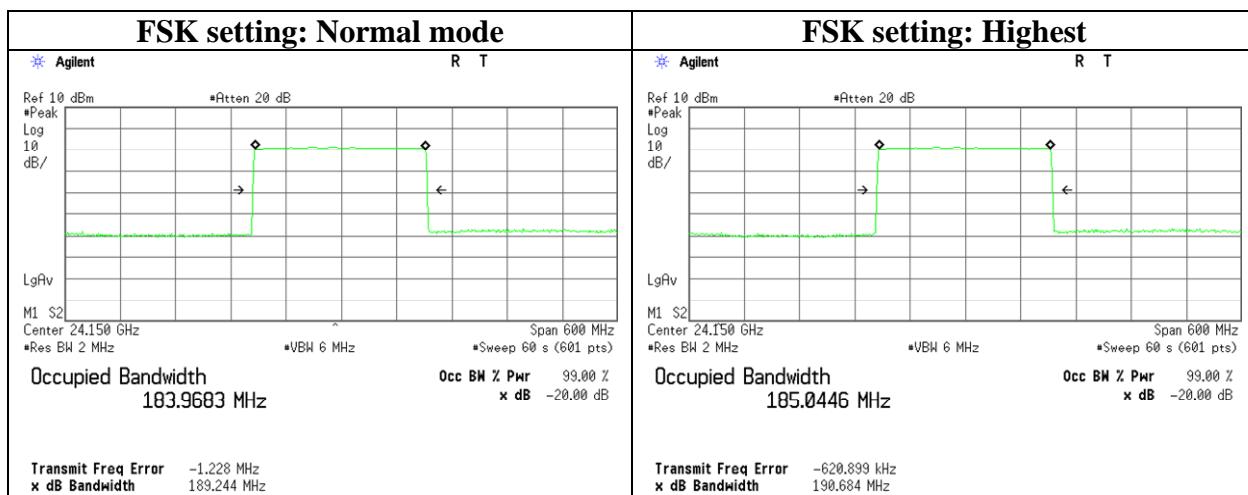
Frequency [GHz]	FSK setting	20 dB Bandwidth [MHz]	99% Occupied Bandwidth [MHz]
24.15	Normal mode	189.487	183.9031
24.15	Highest	190.466	184.5795



20dB Bandwidth, 99% Occupied Bandwidth

Test place Ise EMC Lab. No. 3 Semi Anechoic Chamber
 Report No. 11741240H
 Date June 15, 2017
 Temperature / Humidity 24 deg. C / 44 % RH
 Engineer Hironobu OHnishi
 Mode Tx 24.15 GHz, Narrow beam(Left)

Frequency [GHz]	FSK setting	20 dB Bandwidth [MHz]	99% Occupied Bandwidth [MHz]
24.15	Normal mode	189.244	183.9683
24.15	Highest	190.684	185.0446



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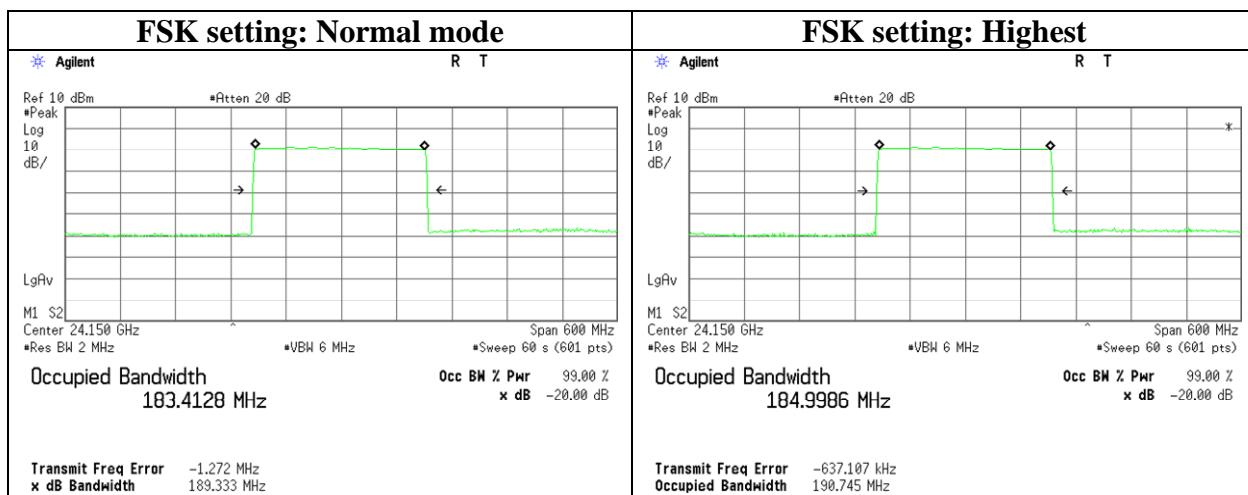
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Facsimile : +81 596 24 8124

20dB Bandwidth, 99% Occupied Bandwidth

Test place Ise EMC Lab. No. 3 Semi Anechoic Chamber
 Report No. 11741240H
 Date June 15, 2017
 Temperature / Humidity 24 deg. C / 44 % RH
 Engineer Hironobu OHnishi
 Mode Tx 24.15 GHz, Narrow beam(Right)

Frequency [GHz]	FSK setting	20 dB Bandwidth [MHz]	99% Occupied Bandwidth [MHz]
24.15	Normal mode	189.333	183.4128
24.15	Highest	190.745	184.9986



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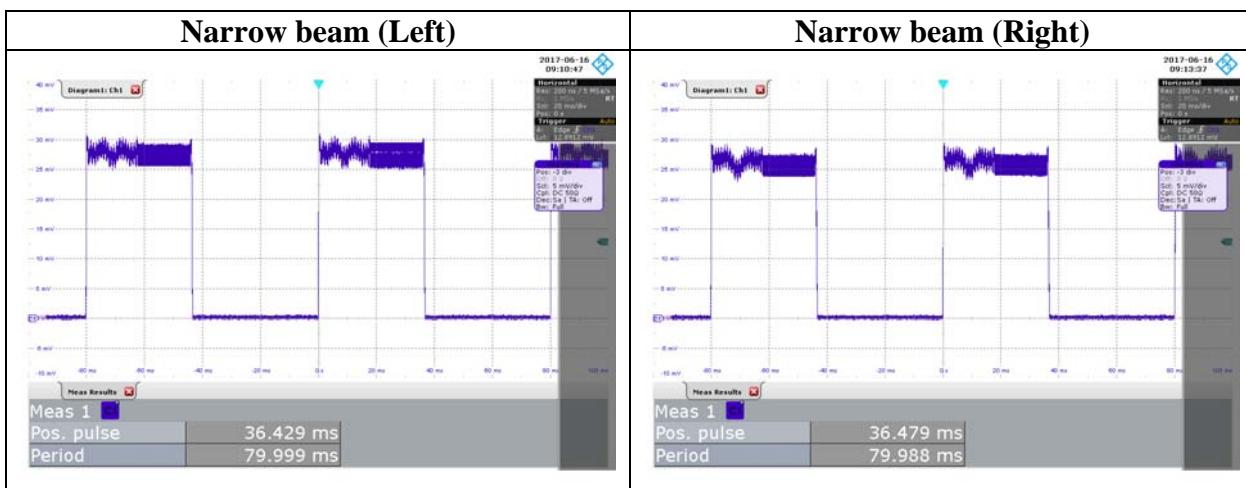
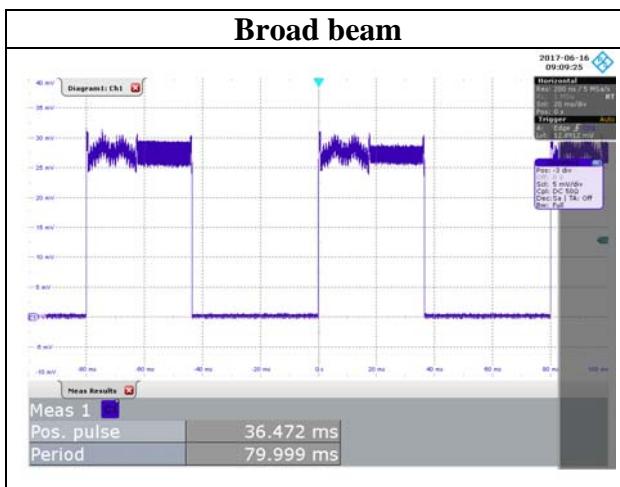
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Duty Cycle

Test place Ise EMC Lab. No. 3 Semi Anechoic Chamber
 Report No. 11741240H
 Date June 16, 2017
 Temperature / Humidity 25 deg. C / 42 % RH
 Engineer Hironobu OHnishi
 Mode Tx 24.15 GHz

Mode	Tx On time [ms]	Tx On + Off time [ms]	Duty factor [dB]
Broad beam	36.472	79.999	-6.82
Narrow beam (Left)	36.429	79.999	-6.83
Narrow beam (Right)	36.479	79.988	-6.82
Declared	36.400	80.000	-6.84

Duty factor = $20 * \log (\text{Tx On time} / \text{Tx On + Off time})$



The declared duty factor and measured one were compared. The maximum duty factor of these results was applied to the average field strength measurement. (Worst case)

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APPENDIX 2: Test Instruments

EMI test equipment

Control No.	Instrument	Manufacturer	Model No	Serial No	Test Item	Calibration Date * Interval(month)
MAEC-03	Semi Anechoic Chamber(NSA)	TDK	Semi Anechoic Chamber 3m	DA-10005	RE	2016/10/20 * 12
MOS-13	Thermo-Hygrometer	Custom	CTH-180	1301	RE	2017/01/20 * 12
MJM-16	Measure	KOMELON	KMC-36	-	RE	-
COTS-MEMI	EMI measurement program	TSJ	TEPTO-DV	-	RE	-
MSA-04	Spectrum Analyzer	Agilent	E4448A	US44300523	RE	2016/11/10 * 12
MCC-167	Microwave Cable	Junkosha	MWX221	1404S374(1m) / 1405S074(5m)	RE	2017/05/29 * 12
MPA-11	MicroWave System Amplifier	Agilent	83017A	MY39500779	RE	2017/03/21 * 12
MHA-16	Horn Antenna 15-40GHz	Schwarzbeck	BBHA9170	BBHA9170306	RE	2017/05/14 * 12
MMM-08	DIGITAL HiTESTER	Hioki	3805	051201197	RE	2017/01/19 * 12
MHA-20	Horn Antenna 1-18GHz	Schwarzbeck	BBHA9120D	258	RE	2017/05/22 * 12
MHA-03	Horn Antenna 26.5-40GHz	EMCO	3160-10	1150	RE(MW)	2016/06/24 * 12
MCC-220	Microwave Cable	HUBER+SUHNER	SF101EA/11PC24/11PC24/2.5M	SN MY1726/1EA	RE	2017/04/06 * 12
MPA-03	Microwave System Power Amplifier	Agilent	83050A	MY39500610	RE	2016/10/03 * 12
MHA-31	Horn Antenna	Oshima Prototype Engineering Co.	A16-186	1	RE	2016/09/01 * 12
MPA-25	Power Amplifier	SAGE Millimeter, Inc.	SBP-4035033018-2F2F-S1	12559-01	RE	2016/11/08 * 12
MHA-09	Horn Antenna	WiseWave	ARH1523-02	10766-01	RE	2016/10/18 * 12
MRENT-131	Preselected Millimeter Mixer	Agilent	11974V	MY30013051	RE	2016/06/27 * 12
MPA-23	Power Amplifier	SAGE Millimeter, Inc.	SBP-5037532015-1515-N1	11599-01	RE	2016/12/26 * 12
MPA-13	Pre Amplifier	SONOMA INSTRUMENT	310	260834	RE	2017/03/27 * 12
MCC-177	Microwave Cable	Junkosha	MMX221-00500DMSDMS	1502S304	DECT	2017/03/13 * 12
MHA-11	Horn Antenna	WiseWave	ARH1023-02	10766-01	RE	2016/10/18 * 12
MPA-18	Pre Amplifier	AmTechs Corporation	LNA-7511025	9601	RE	2016/08/19 * 12
MMX-02	Harmonic Mixer	Agilent	11970W	2521 A01909	RE	2016/06/20 * 12
OSC-01	Digital Oscilloscope	Rohde & Schwarz	RTO1004	200355	RE	2016/08/12 * 12
MDT-05	Detector	HEROTEK, INC.	DT1840P	484823	RE	Pre Check
MTR-08	Test Receiver	Rohde & Schwarz	ESCI	100767	RE	2016/09/15 * 12
MLPA-01	Loop Antenna	Rohde & Schwarz	HFH2-Z2	100017	RE	2016/10/14 * 12
MCC-112	Coaxial cable	Fujikura/Suhner/TSJ	5D-2W(10m)/SFM141(3m)/sucuform141-PE(1m)/421-010(1.5m)/RFM-E321(Switcher)	-/00640	RE	2016/07/26 * 12
MCC-143	Coaxial Cable	UL Japan	-	-	RE	2017/06/12 * 12
MAT-70	Attenuator(6dB)	Agilent	8491A-006	MY52460153	RE	-
MBA-03	Biconical Antenna	Schwarzbeck	BBA9106	1915	RE	2016/10/15 * 12
MLA-22	Logperiodic Antenna(200-1000MHz)	Schwarzbeck	VUSLP9111B	911B-191	RE	2017/01/26 * 12
MCC-51	Coaxial cable	UL Japan	-	-	RE	2016/07/26 * 12
MAT-98	Attenuator	KEYSIGHT	8491A	MY52462349	RE	2016/12/05 * 12
MCC-135	Microwave Cable	HUBER+SUHNER	SUCOFLEX102	37511/2	RE	2016/08/03 * 12
MCC-136	Microwave Cable	HUBER+SUHNER	SUCOFLEX102	37512/2	RE	2016/08/03 * 12

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The expiration date of the calibration is the end of the expired month.

[Below 40 GHz]

All equipment is calibrated with valid calibrations. Each measurement data is traceable to the national or international standards.

[Above 40 GHz]

Acceptance criteria for untraceable equipment was formulated according to ISO/IEC 17025 5.6.2.2.2, and the regular inspection was performed based on it annually.

For 40 GHz – 110 GHz, power sensor is calibrated by manufacturer, and the measured calibration data is used as in-house reference. The calibration data by manufacturer is checked for acceptance by a calorie meter except for some frequency bands. Electric power is checked with the calorie meter by measuring resistance and voltage of reference resistor.

As for some calibrations performed after the tested dates, those test equipment have been controlled by means of an unbroken chains of calibrations.

Test Item:

RE: Radiated emission, Bandwidth and Duty cycle tests

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